

Notice of References Cited	Application/Control No. 10/526,872		Applicant(s)/Patent Under Reexamination CUMPSON ET AL.	
	Examiner James L. Habermehl		Art Unit 2651	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0081045 A1	04-2004	Won et al.	369/047.33
*	B	US-6,553,501 B1	04-2003	Yokoe, Yuji	713/320
*	C	US-2004/0015731	01-2004	Chu et al.	713/300
*	D	US-6,987,635 B2	01-2006	Akagi et al.	360/69
*	E	US-6,928,039 B2	08-2005	Millikan et al.	369/47.33
*	F	US-2005/0216674 A1	09-2005	Robbin et al.	711/138
*	G	US-2003/0067847 A1	04-2003	Silvester, Kelan C.	369/30.23
*	H	US-6,958,960 B2	10-2005	Sasaki, Yoshiyuki	369/47.28
*	I	US-6,892,313 B1	05-2005	Codilian et al.	713/323
*	J	US-6,590,730 B2	07-2003	Veltchev et al.	360/69
*	K	US-5,943,307 A	08-1999	Takagi et al.	369/47.33
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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